

ABSTRACT OF THE DISCLOSURE

In an active-drive type pixel structure comprising at least TFT for control, TFT for drive, and a capacitor for charge retention, it can be easily inspected whether the functions of TFTs and the capacitor are normal or not. In an active-drive type pixel structure comprising TFT (Tr1) for control, TFT (Tr2) for drive, and a capacitor for charge retention, one terminal of a dummy load W for inspection is connected to a drain of the TFT for drive, and the other terminal of the load W is connected to a line 3 for inspection. By measuring an electric current I_d obtained on the line 3 for inspection while changing a voltage supplied to a data line 2a, it can be inspected whether the functions of TFTs and the capacitor are normal or not. The dummy load W is configured to be melted and cut by burning off the load W with a laser beam or by passing a predetermined electric current in the load W after completion of inspection.